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Liquid Metal Magnetohydrodynamic Pump for Junction Temperature Control of Power Modules

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Abstract— Power modules are the most common components to fail in power converters that are employed in mass transportation systems, thus leading to high unscheduled maintenance cost. While operating, high junction temperature swings occur that result in high thermomechanical stress within the structure of the power module reducing the lifetime of the module. Liquid metals as a cooling medium received so far little attention in the area of power semiconductors cooling, despite being able to remove high heat fluxes. This paper shows for the first time how liquid metal is used to reduce actively the junction temperature swing. A magnetohydrodynamic (MHD) pump has been designed for this purpose allowing active control of the flow rate of the liquid metal that impinges against the baseplate of the module. The pump has been 3D printed and forms with the power module a unique unit. A closed-loop temperature control system is implemented, able to estimate the IGBT’s junction temperature and thus, control the MHD power. The paper presents simulation and experimental results showing reductions in the temperature swing over the full load cycle with 12°C as the highest observed reduction rate. The paper shows also detailed designs of the MHD pump and the controller hardware.

Index Terms — IGBT power module cooling, reliability, liquid metal cooling, magnetohydrodynamic pump, junction temperature

I. INTRODUCTION

APPLICATIONS such as offshore wind power, subsea drilling and railway, require power converter systems that demonstrate high life spans, as cost for unscheduled maintenances can be extremely high for these applications. Many components, such as power semiconductor modules [1], capacitors [2], and printed circuit boards (PCBs) [3] are reliability critical for the power converter operation. This study focuses on
increasing the lifetime of power semiconductor devices. A lifetime model for estimating the cycles to failure of a power semiconductor module was developed in the 90s by the LESIT research program [4]. In that program the number of cycle to failure \((N_f)\) for a power module is expressed as a function of its working conditions, such as the junction temperature swing \((\Delta T_j)\) and the mean junction temperature \((T_m)\), as shown in (1):

\[
N_f = a \cdot (\Delta T_j)^n \cdot e^{E_a / (k_B T_m)}
\]

where \(a\) and \(n\) are material dependent coefficients, \(E_a\) is the activation energy and \(k_B\) is the Boltzmann constant. The outcomes of the LESIT study are illustrated in Fig. 1 [4], clearly showing that the most influencing factor for power modules failures is \(\Delta T_j\). Reducing the temperature fluctuations, even at the cost of operating at a higher mean temperature, could dramatically increase the lifespan of IGBT power modules.

Further research has shown that the lifetime of power electronic modules depends on many other parameters, including the pulse duration, the current amplitude and other packaging parameters, however, the dominant factor for power electronic failures remains the junction temperature swing, \(\Delta T_j\) [5].

![Fig. 1. Power cycling results from LESIT project, showing the dependency of power modules lifespan \(N_f\) on junction mean temperature \(T_m\) and junction temperature swing \(\Delta T_j\) [4].](image)

Fig. 2 shows the schematic of a common power module. Its structure consists of many layers of different
materials, each one owning a different coefficient of thermal expansion (CTE). During large temperature fluctuations, a shear force is generated between the layers because of the mismatch in the CTE of the power module's materials. Hence, the thermomechanical stress within the layers consequently leads to devices' failures such as bond wire lift-off [6] and solder joint fatigue [7]. Thus, reducing temperature fluctuations by reducing the amplitude of $\Delta T_j$ can prolong the lifetime of power modules and reduce the possibility of a failure [8].

In order to keep power semiconductors below the maximum allowable operating temperature, water is widely used as a cooling medium. Most commonly, water pipes are routed in a cold plate in a meander structure [9]. In recent years, research has been focused on further enhancing liquid cooling effectiveness by introducing techniques, such as micro/mini-channel based heat sinks, impingement based techniques and two-phase cooling, to meet the cooling requirements of high power-dense power electronics [10-14]. Lately, liquid metals have been introduced as coolants, as they have a much higher thermal conductivity compared to water. The design, development and fabrication process of an magnetohydrodynamic (MHD) pump has been reported for a few cooling applications, such as cooling high-performance CPUs [15-17], high-power light emitting diodes [18], high-power laser diodes [19], and power switching modules [20, 21]. In all of these applications, MHD pumps were operated at constant power to protect the power module from thermal runaway. In addition, in the previous examples the liquid metal is contained within the pipes of the cooling system. Hence, the excess heat is dissipated without the coolant contacting the baseplate of the power module directly, which introduces additional resistance for the thermal path. The implementation of an adaptive forced-air cooled heat sink was presented in [22] and [23], demonstrating an increase in the lifetime of power
electronic devices through power cycling tests. Nonetheless, with the ever-increasing power densities of power electronics, air-cooled technologies are unable to dissipate the excess heat [9]. In addition, an adaptive thermoelectric cooling (TEC) was presented in [24]. However, as TECs need to dissipate the heat that is being moved from the semiconductor chip and the heat that is generated from its own power, their heat dissipation capability is limited [25].

This paper presents for the first time the design, development and implementation of an MHD-driven, liquid metal heat sink that can be used for cooling and for actively reducing the amplitude of the junction temperature cycle of an Insulated Gate Bipolar Transistor (IGBT) power module through active control of the junction temperature. Moreover, the pump is integrated to the power module and impinges liquid metal to its baseplate directly, thus reducing the overall thermal resistance of the system by eliminating the need for thermal grease.

The paper is structured as follows: Section II introduces the principal methodology and the control structure to reduce the junction temperature swing and shows simulation results. Section III describes the liquid metal MHD pump design that has been used in the experiment. The experimental test set-up is described in Section IV. Experimental results demonstrating reduction in temperature variations are shown in Section V. Section VI concludes the work.

II. PRINCIPAL METHODOLOGY AND CONTROL STRUCTURE

A. Time-dependent Thermal Cycles of Power Modules

In real applications, the temperature profile of power semiconductors is jointly determined by operating and environmental conditions, whose dynamic changes in terms of time constants generally shows diverse differences, as shown in Fig. 3. The time constants governing the device and circuit electrical properties usually range from sub-microseconds to milliseconds and are related to the characteristic performance of the switching device and switching frequency of the power converter. Similarly, the time constant of a mechanical system typically including the motor drive, shaft and mechanical load could vary from
sub-seconds to several minutes. Finally, the long term thermal cycle is associated with environmental changes, such as the day-night and seasonal alternation-driven temperature variation or geographical/spacious relocation-driven temperature changes. Power modules are subjected to cyclic thermomechanical stresses resulted from the superposed temperature deviations mentioned above. Power modules are mostly stressed because of load changes with regards to the mechanical system requirement, which is always accompanied by large temperature swings occurring at a substantial frequency [18]. Changes associated with environmental temperature contribute to the module ageing, however, they are outperformed by the load cycling [26]. On the other hand, temperature cycles caused by the device switching action and circuit topological alternations result in very small amplitude that does not greatly impact the lifetime of a healthy power semiconductor module [27]. That is partly because the thermal variation caused by higher frequencies is counterbalanced by the capacitance of the thermal circuit, and partly because the thermal strain is counterbalanced by the elastic deformation of the power module’s materials.
B. Enable Proactive Thermal Management using Adaptive Heatsink

In order to reduce the significant thermal cycles dominated by load changes in the mechanical time constant range, an adaptive heat sink can be designed to offset the temperature variations by adjusting its inherent cooling performance. This will then reduce the module's fatigue and therefore, increase the lifetime of power semiconductor devices. The proposed temperature control scheme is achieved by employing an actively controlled liquid metal heat sink enabled by an MHD pump that changes the coolant’s flow rate in terms of the change of the junction temperature \( T_j \).

Fig. 4(a) shows a typical Cauer thermal network of an IGBT power module cooled by a water cooling heat sink, where the cold plate is emulated by the \( n_{th} \) node of the resistance - capacitance (RC) ladder. The Cauer network has a physical basis, as each RC element represents a physical layer of the module. These RC networks are constant and Fig. 4(a) assumes that all of the heat produced in the semiconductor chip travels through all module layers into the coolant. As the total thermal resistance is fixed, the junction temperature becomes only a function of power losses \( P(t) \) and the water temperature \( T_{water} \). In comparison, in Fig. 4(b) the water cold plate is replaced by an active liquid metal heatsink powered by the MHD pump, which is positioned directly under the base plate to achieve a small form factor by integrating the MHD pump with the heat sink. The thermal resistance \( R_{thn} \) of the new heat sink is adjustable and as demonstrated in [28], and the value of \( R_{thn} \) is a function of the liquid metal flow rate \( Q \). The variable thermal resistor is controlled in such a way that it is changing the cooling rate in order to minimize \( \Delta T_j \). Similarly, \( T_{lm} \) represents the liquid metal’s inlet temperature.
C. Comparison of Thermal Networks and their Cooling Capabilities

An 8th order Cauer thermal network was developed for simulating the junction temperature of an IGBT die in a power semiconductor module, where the first 7 Cauer elements represent the IGBT device and the 8th element emulates the liquid metal MHD pump. Fig. 5 shows the schematic of the circuit including the principal control structure, which was simulated in PLECS. The losses of the IGBT switch are emulated by an input signal that is fed to the power source, $P(t)$. The junction temperature is compared to a reference temperature and the error between those two values is fed to a proportional controller. Hence, the value of the variable thermal resistance is changed based on the instantaneous IGBT junction temperature, in order to reduce the junction temperature fluctuation, $\Delta T_j$. A proportional controller was selected, as the proposed scheme considers temperature changes dominated by the mechanical system of a relatively large time constant. The gain value ($k_p = 0.2$) is selected based on the overall thermal resistance boundaries of the system. Table I shows the thermal parameters of the IGBT module that is used for the experiment (SEMIKRON SKM 50GB063D), which were extracted from [29]. The traditionally used thermal grease layer is omitted due to the direct interface between the module and the liquid metal. The experimental results in [20] have demonstrated a thermal resistance of 0.094 °C/W for a liquid metal heatsink used in a power
electronics cooling application. The maximum thermal resistance limit of 3 °C/W was obtained empirically. Hence, the thermal resistance $R_{th8}$ is set between 0.094 °C/W and 3 °C/W, where the liquid metal flow rate is maximum at the minimum thermal resistance limit and zero at the maximum thermal resistance limit.

![Simulation schematic of IGBT temperature control scheme.](image)

**Fig. 5.** Simulation schematic of IGBT temperature control scheme.

Power modules used in electric rail traction applications are expected to have at least 30 years of reliable operation that corresponds to several millions of power cycles [30], therefore, a metro-system mission profile was selected for this study [31]. A repeating cycle that consists of the following steps was applied to the simulation model: accelerating for 41 s, travelling at 60 km/h for 37 s, braking for 10 s, travelling at 40 km/h for 11 s, braking for 22 s and finally, making a complete stop for 30 s. The original mission profile is scaled down, with the maximum load current capped to 50 A to meet the requirements of the selected IGBT module (the maximum current used later in the experiment is also limited to 50 A). The simulation results are presented in Fig. 6. The scaled down mission profile has been converted into a simplified power loss profile $P_{(t)}$ that accounts only for the on-state losses, as shown in Fig. 6(a). Based on the actual junction temperature

<table>
<thead>
<tr>
<th>Material</th>
<th>Cauer node</th>
<th>Thermal resistance (°C/W)</th>
<th>Thermal capacitance (J/°C)</th>
</tr>
</thead>
<tbody>
<tr>
<td>Silicon die</td>
<td>1</td>
<td>0.0319</td>
<td>0.015</td>
</tr>
<tr>
<td>Die attach</td>
<td>2</td>
<td>0.037</td>
<td>0.0047</td>
</tr>
<tr>
<td>Copper</td>
<td>3</td>
<td>0.0155</td>
<td>0.05</td>
</tr>
<tr>
<td>Aluminum oxide</td>
<td>4</td>
<td>0.2411</td>
<td>0.078</td>
</tr>
<tr>
<td>Copper</td>
<td>5</td>
<td>0.0108</td>
<td>0.072</td>
</tr>
<tr>
<td>DCB solder</td>
<td>6</td>
<td>0.0211</td>
<td>0.0082</td>
</tr>
<tr>
<td>Baseplate</td>
<td>7</td>
<td>0.054</td>
<td>1.394</td>
</tr>
<tr>
<td>Liquid metal heat sink</td>
<td>8</td>
<td>0.094 – 3</td>
<td>50</td>
</tr>
</tbody>
</table>
T_\text{j} \text{ variation and the reference temperature } T_{\text{ref}}=50^\circ\text{C} \text{ the controller minimizes temperature swings } \Delta T_\text{j} \text{ by manipulating the thermal resistance } R_{\text{th8}}. \text{ The change of } R_{\text{th8}} \text{ over time is shown in Fig. 6(b). It is shown that } R_{\text{th8}} \text{ decrease with rising } P(t), \text{ and vice versa. During the stop mode of the metro, the MHD pump is commanded to stop pumping liquid metal resulting in a constant high value of } R_{\text{th8}}=3^\circ\text{C/W} \text{ during this period, whereas a minimum thermal resistance is required during dynamic accelerating/braking.}

Adaptive cooling intends to mitigate the thermal stresses compared to the constant cooling based on the comparison of the junction temperatures T_\text{j} \text{ evolution over the full mission profile. Fixing } R_{\text{th8}} \text{ represents the use of a cold plate with constant flow rate and this scenario can therefore be regarded as a standard cold plate as shown in Fig. 4(a). The thermal resistance value for the latter simulation was set to its lowest value of } R_{\text{th8}}=0.094^\circ\text{C/W}. \text{ Fig. 6(c) shows an evident impact on } \Delta T_\text{j} \text{ reduction for an adjustable } R_{\text{th8}}. \text{ Particularly, both the maximum junction temperature swing and the frequency of } \Delta T_\text{j} \text{ swing with large amplitude are reduced. Over the full metro mission profile, } \Delta T_\text{j} \text{ of the adaptive cooling is much smaller compared to } \Delta T_\text{j} \text{ of constant cooling. The adaptive cooler achieves its highest temperature swing reduction during the acceleration from standstill to maximum speed. In this mode the junction temperature changes by 18^\circ\text{C} \text{ using the controlled MHD pump compared to 33^\circ\text{C} when uncontrolled. This is nearly a 50\% reduction in temperature swing. Fig. 6(c) shows that the mean junction temperature } T_m \text{ of the adaptive cooling is 44^\circ\text{C} and 35^\circ\text{C for the cold plate with fixed } R_{\text{th8}}. \text{ The rise in the mean temperature is the result of the tighter control of the junction temperature. The uncontrolled cold plate produces more frequent and longer colder junction temperatures over time which in average brings down the mean junction temperature value. In spite of the higher mean junction temperature of the device while } T_\text{j} \text{ is actively controlled, the thermal stress within the module's layers is reduced.}
The simulated temperature control scheme relies on accurate junction temperature measurement, however, implementing a temperature estimation technique in the real design is not a trivial task. In this work, a Temperature Sensitive Electrical Parameter (TSEP) is employed for sensing $T_j$ and it is discussed in detail in Section IV. In addition, the thermal resistance of the active heat sink is adjusted instantly in line with the changing junction temperature, which is not the case for the proposed liquid metal heat sink, as the thermal resistance is associated with the liquid metal flow rate and therefore, a certain period of time is required before it reaches steady state. Hence, time delays that might occur during the variation of the liquid metal flow rate have not been taken into consideration for the simulation but will be discussed in the experimental setup.
III. LIQUID METAL MHD PUMP

A. Active Heat Sink Structure

The self-contained liquid cooling system consists of two parts; a MHD pump head with direct immersion cooling and a U-type tubular liquid metal-to-water heat exchanger with connection pipes. Fig. 7 shows the schematic drawing and the implementation of the cooling system. The SEMIKRON SKM 50GB063D is used as the device-under-test (DUT). The DUT is bolt on the pump head and there is a direct interface between the backside of the baseplate and the liquid metal coolant. The coolant flowing is confined to the designed liquid block and directed by two narrow slots in the Nylon housing, as shown in Fig. 8(a). The liquid block is sealed with an o-ring. The heat source is in direct contact with the liquid metal which impinges the baseplate as illustrated by Fig. 8(b). The U-type heat exchanger and the pump head are connected with two short pipes to form a closed loop. The pump is positioned beneath one IGBT chip of the half bridge module, as this is the only one used in the experiment. The 3D printed housing of the pump head is made of engineering plastic (VeroWhite™), which is able to provide good electrical insulation, good waterproofness, good chemical resistance and sufficient rigidity. The main disadvantage of the selected material is its relatively low glass transition temperature $T_g$, which equals 52°C. That is the point at which the material transitions from hard to soft. The 3D printed material is utilized in this study to demonstrate the effectiveness of the proposed heat sink in reducing the temperature fluctuation of $T_j$ in a laboratory environment, however, for a real-case application, a material with a higher $T_g$ should be selected.
Fig. 7. Schematic diagram of the cooling circuit.

Fig. 8. Detailed view of the active liquid metal cooler: (a) bottom view of the cooler and (b) isometric view of the cooler and IGBT module.
B. Construction of the MHD Pump

Two MHD micro-pumps are integrated in the plastic housing, where totally five magnets are embedded in \( x \) direction and a pair of nickel electrodes is embedded in \( y \) direction and thus, perpendicular to the magnets. The coolant used for this application is the eutectic alloy \( \text{Ga}_{68}\text{In}_{22}\text{Sn}_{10} \) (68% Ga, 22% In and 10% Sn). It has a similar composition to Galinstan\textsuperscript{TM} and its thermophysical properties are shown in Table II. Compared to water, which is widely used as a cooling medium for power electronic applications, \( \text{Ga}_{68}\text{In}_{22}\text{Sn}_{10} \) has a much lower specific heat capacity \( (C_p) \). Hence, its volumetric heat capacity \( (C_v=\rho \cdot C_p) \) is about 55% lower compared to water’s volumetric heat capacity. Nonetheless, \( \text{Ga}_{68}\text{In}_{22}\text{Sn}_{10} \) has a higher cooling capability due to its high thermal conductivity, which is approximately 27.2 times larger than water’s thermal conductivity.

<table>
<thead>
<tr>
<th>Property</th>
<th>Unit</th>
<th>Water</th>
<th>( \text{Ga}<em>{68}\text{In}</em>{22}\text{Sn}_{10} )</th>
</tr>
</thead>
<tbody>
<tr>
<td>Density</td>
<td>kg/m(^3)</td>
<td>998</td>
<td>6400</td>
</tr>
<tr>
<td>Melting point</td>
<td>°C</td>
<td>0</td>
<td>-19</td>
</tr>
<tr>
<td>Boiling point</td>
<td>°C</td>
<td>100</td>
<td>&gt;1300</td>
</tr>
<tr>
<td>Specific heat capacity</td>
<td>J/(kg·°C)</td>
<td>4181</td>
<td>365</td>
</tr>
<tr>
<td>Dynamic viscosity</td>
<td>Pa·s</td>
<td>0.001</td>
<td>0.0024</td>
</tr>
<tr>
<td>Electrical conductivity</td>
<td>S/m</td>
<td>5.5·10(^{-6})</td>
<td>3.46·10(^{6})</td>
</tr>
<tr>
<td>Thermal conductivity</td>
<td>W/(m·°C)</td>
<td>0.606</td>
<td>16.5</td>
</tr>
<tr>
<td>Prandtl number</td>
<td>-</td>
<td>6.62</td>
<td>0.027</td>
</tr>
</tbody>
</table>

As Fig. 9 shows, because there is a constant magnetic field in \( x \) plane, injecting current through the electrodes in \( y \) plane, generates Lorentz force in \( z \) plane that is used for driving the conducting fluid in the
channels of the pump. When a current is applied across the width of a channel filled with a conductive fluid subjected to an orthogonal magnetic field, the Lorentz force exerts body force on the fluid that is proportional to both the generated current density \(J\) in the fluid and the magnetic flux density \(B\), as expressed in (2):

\[
F = \int J \times B \cdot dV \approx B_{\text{eff}} I_{\text{pump}} L
\]  

where \(dV\) is the active volume of the pump, \(B_{\text{eff}}\) is the efficient magnetic flux density, \(I_{\text{pump}}\) is the current through the electrodes and \(L\) is the current flow distance between the two electrodes. Eq. (2) assumes that \(B\) and \(J\) are homogeneous and constant. The relationship between the pressure developed by the pump and mean velocity can be derived, as the flow in the system is pressure driven, shown in (3):

\[
P_{\text{MHD}} = \frac{F}{A} \approx \frac{B_{\text{eff}} \cdot I_{\text{pump}}}{d} \approx C_1 \cdot \rho u^2 + C_2 \cdot \rho u
\]  

where \(P_{\text{MHD}}\) is the pressure developed by the pump and \(A\) is the cross section of the pump with length \(L\) and width \(d\), \(u\) is the mean velocity across the channel, and finally, \(C_1\) and \(C_2\) are the coefficients of flow resistance through the system, considering pumps, piping and the tank of the loop. The flow rate across the pump, \(Q\), can therefore be expressed as:

\[
Q = uA = \left( \frac{C_2^2 + \frac{8B_{\text{eff}} I_{\text{pump}} C_1}{\rho \pi r}}{2C_1} \right) \cdot \frac{\pi r^2}{2C_1}
\]  

where \(r\) is the radius of the tube and \(\rho\) is the fluid density. Eq. (4) shows a clear relationship between the flow rate \(Q\) and the applied current \(I_{\text{pump}}\), which can be used to calculate the coolant’s flow rate. In this work, coefficients \(C_1\) and \(C_2\) were determined by computational fluid dynamics (CFD) simulations, whereas \(B_{\text{eff}}\) was obtained empirically. Hence, for a specific current value, the flow rate can be predicted and applied in the CFD simulation to estimate the thermal characteristics of the liquid metal heat sink. The design parameters for the developed pump are shown in Table III and Fig. 10. The main disadvantage for implementing the
proposed cooling scheme is the cost increase of the converter’s thermal management that is mainly driven by the cost of the liquid metal, which is always more expensive compared to water even if mass-produced. However, substantial operational cost savings can be made with the proposed scheme as power modules will be utilized for a longer period. In addition the implementation of a liquid metal cooling system reduces the overall weight and volume of the cooling system significantly [31].

![Fig. 10. Dimensions of the MHD pump in mm (front view).](image)

**TABLE III**  
**LIQUID METAL MHD PUMP DESIGN PARAMETERS**

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Symbol</th>
<th>Unit</th>
<th>Value</th>
</tr>
</thead>
<tbody>
<tr>
<td>Cross sectional area of MHD channel</td>
<td>( A )</td>
<td>mm(^2)</td>
<td>( 2 \times 10^1 )</td>
</tr>
<tr>
<td>Magnetic field cross sectional area</td>
<td>( A_{mag} )</td>
<td>mm(^2)</td>
<td>( 1 \times 10^2 )</td>
</tr>
<tr>
<td>Efficient magnetic flux density</td>
<td>( B_{eff} )</td>
<td>T</td>
<td>0.3</td>
</tr>
<tr>
<td>Inner liquid metal pipe radius</td>
<td>( r )</td>
<td>mm</td>
<td>3</td>
</tr>
<tr>
<td>Channel distance between magnets</td>
<td>( d )</td>
<td>mm</td>
<td>2</td>
</tr>
<tr>
<td>Coefficient 1</td>
<td>( C_1 )</td>
<td>-</td>
<td>( 6 \times 10^{-4} )</td>
</tr>
<tr>
<td>Coefficient 2</td>
<td>( C_2 )</td>
<td>-</td>
<td>( 19 \times 10^{-4} )</td>
</tr>
</tbody>
</table>

Characterization of the pump for a range of input current values was also performed, in order to estimate \( B_{eff} \), which is achieved by measuring the static pressure (\( P_s \)) for different current values. Once the pump is attached to the IGBT module, its slots and the piping system are filled with the liquid metal and positioned vertically. Then, a PWM controlled current, \( I_{pump} \), is injected from a power supply unit (Agilent 6684A) to the pump’s electrodes and the height difference (\( \Delta H \)) between the inlet and outlet tubes is measured at the point
where the liquid metal reaches its equilibrium position. Hence, in this position $P_{\text{MHD}}$ equals the static pressure $P_s$, which can be defined as:

$$P_{\text{MHD}} = P_s = \rho g \Delta H$$

where $g$ is the gravitational acceleration. In Fig. 11, the static pressure $P_s$ is shown as a function of the supplied current $I_{\text{pump}}$. As expected, for a constant magnetic field, the static pump pressure varies linearly with the injected current. Therefore, $B_{\text{eff}}$ is estimated by rearranging (3) and is shown in Table III.

![Graph showing static pressure $P_s$ as a function of input current $I_{\text{pump}}$.]

**Fig. 11.** MHD pump characterization: static pressure $P_s$ as a function of input current $I_{\text{pump}}$

### IV. EXPERIMENTAL TEST SETUP

#### A. Experimental Rig

A liquid metal-to-water heat exchanger is employed in this work for its power heat dissipation. The heat exchanger uses a U-shaped nickel pipe that accommodates the liquid metal and can be directly jointed with the inlet and outlet orifices of the MHD pump, although soft plastic connectors are used here for the ease of experimental connection. The heat exchanger pipe was made of nickel, as this material has high chemical resistivity against Ga$_{68}$In$_{22}$Sn$_{10}$. The pipe of the heat exchanger uses the same diameter as the inlet and outlet of the pump, in order to reduce the flow resistance in the loop. The slots of the MHD pump are the only points in the liquid metal loop that are narrower, in order to achieve high pressure for driving the coolant. The pipe is housed in an aluminum tank, which provides a water jacket from a liquid chiller unit (Cosmotec WRA70) with a predefined temperature. A flow meter ($Q_w$), pressure transducers ($P_{\text{w-in}}$ and $P_{\text{w-out}}$), and
thermocouples ($T_{\text{w-in}}$, $T_{\text{w-out}}$, $T_{\text{lm-in}}$ and $T_{\text{lm-out}}$) are used for monitoring the water flow rate, the pressure drop across the heat exchanger and the inlet and outlet temperatures of water and liquid metal, respectively, as shown in Fig. 7. The liquid metal heat sink was subjected to both static and dynamic tests, to evaluate its cooling capability and its effectiveness in reducing the junction temperature fluctuations caused by load current changes. The schematic diagram of controlled load current and junction temperature measurement using a TSEP is shown in Fig. 12(a), whereas the experimental setup is presented in Fig. 12(b). The IGBT power module remains in its forward conducting state for the duration of the whole experiment, by applying a gate-emitter voltage of $+15$ V. A pulse DC current ($I_{\text{heat}}$), supplied by a TopCon Quadro programmable power supply unit, is emulating the heat losses ($P_{\text{heat losses}}$) produced by the IGBT chip.

![Schematic diagram of IGBT heating and temperature sensing and experimental setup](image)

**Fig. 12.** Experimental setup: (a) Schematic diagram of IGBT heating and temperature sensing and (b) pictures of test bed

**B. Junction Temperature Measurement**

The chip junction temperature is required to evaluate the thermal properties of the heat sink. An indirect method via a TSEP was used for estimating the junction temperature. The temperature dependency of $V_{\text{CE-on}}$...
on $T_j$ for IGBTs at a low forward conduction current is obtained through a preliminary TSEP calibration test, where a hotplate was used to control the temperature of the IGBT chip externally. The TSEP calibration curve is shown in Fig. 13. A 100 mA sense current ($I_{\text{sense}}$) was selected in this study, as it provides high resolution (-2.14 mV/°C) without contributing to the self-heating of the IGBT device [7, 32]. For thermal characterization, the TSEP measurement takes place when the pulsed heating current $I_{\text{heat}}$ is zero and only $I_{\text{sense}}$ conducts. A dead time of 1 ms was added before measurement takes place in order to avoid measurement errors caused by the noise during the turn-off process. Then five consecutive $V_{\text{CE-on}}$ samples are obtained with a 10 μs delay between them. A median filter is therefore applied for the estimation of $T_j$. An example input waveform, used for both heating the IGBT and measuring $T_j$, is shown in Fig. 14.

![Fig. 13. TSEP calibration curve, showing the dependency of on-state voltage $V_{\text{CE-on}}$ on junction temperature $T_j$ for 100 mA forward conducting current.](image1)

![Fig. 14. Example waveform for IGBT heating and junction temperature measurement](image2)
C. Evaluation of the Cooling Capacity

It is essential to identify the cooling performance and heat dissipation capability of the liquid metal heat sink and to set boundaries in its operation. This was firstly evaluated with CFD simulations and verified with experimental results.

The conjugate heat transfer of MHD pump was simulated in ANSYS CFX 12.0, in which 3-D steady Reynolds-averaged Navier-Stokes (RANS) equations are solved for the fluid flow and energy equations are solved for fluid and solid simultaneously for the heat transfer. A few basic settings and assumptions are applied for the simulation i.e. (i) the flow is incompressible, (ii) the buoyancy and radiation heat transfer are not taken into account (iii) and the thermophysical properties of the liquid metal are temperature independent.

The shear-stress-transport (SST) model is chosen as the turbulence model. Grid independence has also been examined, after which the grid of the solid domain has 111,292 nodes, and the grid of fluid domain has 195,245 nodes, which corresponds to a maximum y+ value of 1.0 on the wall boundary. Smooth wall conditions have been implemented over the wall. High resolution advection scheme is used too for the calculation of the advection terms, and root mean square residual of smaller than $10^{-5}$ is set as the convergence criterion. Results from the CFD analyses are shown in Fig. 15 and Fig.16. Fig. 15 represents the thermal characterization in a 3D plot for when the supplied pump current $I_{pump}$ was varied between 0A and 15A and power losses $P_{heat\_losses}$ where varied between 0W and 40W. From Fig. 16 it can be concluded that the thermal resistance of the system is a function of the MHD pump’s input current $I_{pump}$, as $T_j$ steadily decreases with an increased current prior to 10 A. However, there is a marginal improvement on thermal conductivity when $I_{pump}$ is higher than 10 A, suggesting the peak heat dissipation capability that will be discussed in the next sub-section.
In the practical experiment the power losses $P_{\text{heat losses}}$ were obtained by multiplying collector current $I_C$ and on-state voltage drop $V_{\text{CE-on}}$ during thermal equilibrium and $T_j$ was measured during the low current interval. When the chip is subjected to a rising power loss ranging from 0 to 40 W, its junction temperature also increases. Experimental results are also shown in Fig. 16 for comparison and the experimental results matches the CFD simulation results.

**D. MHD Pump Control**

The dynamic thermal performance of the heat sink is evaluated for different values of $I_{\text{pump}}$ and the system time constant ($\tau_{\text{MHD}}$) is derived and illustrated in Fig. 17. As shown, the time required for the junction temperature, $T_j$ to reach its steady state from a predefined temperature of 70°C is a function of $I_{\text{pump}}$. The time constant of the IGBT module is comparatively small and can be neglected. The results show that $\tau_{\text{MHD}}$ is dependent on the liquid metal flow rate, and therefore, the MHD pump current $I_{\text{pump}}$. Consequently, at higher input pump current, $I_{\text{pump}}$, heat in the baseplate is removed faster by the liquid metal coolant. For example, a
15 A continuous pump current for 10 s will bring the junction temperature into steady state. The relation between the time of heat removal $\tau_{\text{MHD}}$ and pump current is however exponential and not linear as shown in Fig. 17 and therefore requires a closed loop control. It should be noted that the glass transition temperature of the pump housing, $T_g = 52^\circ\text{C}$, cannot be exceeded. Otherwise, the thin nylon walls of the inlet and outlet slots in the liquid block could be damaged, as they are constantly subjected to the magnetic force generated by the embedded magnets of the MHD pump. Therefore, the characterization process for the current design was limited for junction temperatures ranging from 20 °C to 70 °C. At 70 °C the liquid metal temperature is about 41 °C which is below 52 °C.

![Fig. 17. MHD system time constant $\tau_{\text{MHD}}$ as a function of the pump current $I_{\text{pump}}$.](image)

Fig. 18 shows the principal control structure for the junction temperature swing $\Delta T_j$ control experiment. The actual junction temperature ($T_j^*$) is measured with the help of the TSEP as indicated in Fig. 13. The obtained $T_j^*$ value is compared to a reference value $T_{\text{ref}} = 50 ^\circ\text{C}$ and an error is generated. A proportional controller with $k_p = 0.5$ is used since the system has a very high time constant. Due to its high electric conductivity, the liquid metal between the electrodes form a current loop that has a rather small ohmic resistance ($\approx 1\text{m}\Omega$) and therefore, very little power is required for driving the liquid metal as shown in Fig. 19. Thus, the electrodes of the MHD pump are connected to a variable controllable dc current source supply that can control the current of up to 15 A. A bench power supply (Agilent 6684A) was used as a current source for the MHD pump, which is a laboratory equipment and cannot be utilized in a real environment. A constant current source that is able to provide the maximum driving current of 15 A with a maximum efficiency of up
to 90% can be used in a real application [33]. The pump current $I_{pump}$ determines the flow rate $Q$ of the liquid metal, which impinges against the baseplate and regulates junction temperature $T_j^*$ at given power losses.

![Block diagram of liquid metal heat sink controller.](image)

**Fig. 18.** Block diagram of liquid metal heat sink controller.

![Consumed power of liquid metal pump as a function of the input current.](image)

**Fig. 19.** Consumed power of liquid metal pump as a function of the input current.

## V. EXPERIMENTAL RESULTS

The effectiveness of the liquid metal heat sink in reducing $\Delta T_j$ is described in this Section. As already discussed, the mechanical load changes have a strong impact on the lifetime consumption of power semiconductor modules. The effectiveness of the proposed heat sink was tested by applying the metro-system mission profile mentioned previously in Section II. The scaled load current profile is presented in Fig. 20.

Two tests were conducted by subjecting the DUT to the same mission profile of Fig. 20; Test 1 - the MHD pump is fixed at a maximum cooling power powered from a constant $I_{pump}=15$ A current supply and Test 2 - the MHD pump is adaptively controlled with $I_{pump}$ varying from 0A to a peak current up to 15A. Test 1 represents cooling to protect the IGBT device from thermal runaway and Test 2 represents cooling and junction temperature, $T_j$, control that aims to extend the lifetime of the power module by reducing $\Delta T_j$. The
results of both tests are shown in Fig. 21. In both experiments the water temperature was fixed at 20°C. The inlet liquid metal temperature, $T_{lm}$, has approximately the same value as water temperature due to the effective heat transfer properties of the heat exchanger.

Fig. 20 shows that the junction temperature swing is greatly reduced with the introduction of the adaptive controller. The largest variations of the temperature are observed during accelerating and braking, as there is a large heat losses during these intervals. Similar to the simulation results, the temperature swing $\Delta T_j$ is reduced while the adaptive temperature controller is activated, in comparison to the case where maximum constant cooling is applied over the full metro-mission profile. The impact of the MHD time constant, $\tau_{MHD}$, can be seen in Fig. 21 when compared with Fig. 6. The variation of the thermal resistance $R_{th}$ for the simulation model is instant, which results in fast changes of the junction temperature. For example, in Fig. 6 $T_j$ is the same for both constant and adaptive cooling at the peak point, during the acceleration phase. On the other hand, during the experimental test there is a difference in the junction temperature $T_j$ between the two cooling schemes during acceleration as a result of the time constant $\tau_{MHD}$ required by the heat sink to reach its steady state. The largest temperature swing occurs for both adaptive and constant cooling during the acceleration of the metro from a full stop to maximum speed. Over the course of a full metro cycle the adaptive cooling scheme manages to decrease the maximum $\Delta T_j$’s from 31°C to 19°C, which corresponds to a 12°C decrease between the two cooling methods. As a consequence, the mean junction temperature is increased by 8°C, which also contributes to the IGBT lifetime consumption, but as previously mentioned, its
impact is not as strong as the temperature fluctuation [4]. Also in Fig. 21, the supplied pump current for each case is shown. With the thermal controller activated, the pump current is constantly changing, which affects the flow rate of the liquid metal and therefore, the thermal resistance of the system. Fig. 21 shows that the average current required by the adaptive cooling scheme is 50% smaller compared to the uncontrolled cooling which decreases the power consumption of the MHD pump.

![Graph showing junction temperature and pump current](image)

*Fig. 20. Junction temperature, $T_j$, results and liquid metal pump supplied current, $I_{pump}$, with and without thermal controller.*

### VI. CONCLUSION

This work presented an active liquid metal cooled heat sink, designed to reduce the temperature swing of the junction temperature in order to increase the lifetime of power modules. A magnetohydrodynamic (MHD) pump, which has no rotating components and thus is simple, reliable and easy to control, was designed to impinge liquid metal against the baseplate of the power module. Both pump and IGBT module form one unit. The pump is controlled by using a simple P-controller that controls the amount of current that flows through the liquid metal in order to generate the exact pump power. As the cooling flow rate is actively
changed, the heat flux from the chip to the baseplate is controlled and therefore the junction temperature can be influenced. Simulation and experimental results have been conducted. The highest temperature swing observed for constant cooling is 31°C, whereas it is reduced to 19°C by implementing the adaptive cooling. Hence, the proposed cooling method achieves a $\Delta T_j$ reduction of 12°C. The paper also presents the design of an MHD pump which becomes an integral part of the power module.

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